

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	48	"semiconductor memory" AND (bitlines OR "bit lines") AND "same logic state"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/17 07:48
S2	32	test AND "semiconductor memory" AND "same logic state"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/17 07:48
S3	2121	(714/724 OR 714/733-734 OR 714/745) AND @ad<"20010809"	US-PGPUB; USPAT	OR	ON	2004/06/17 07:53
S4	167	test AND "same logic state" NOT "semiconductor memory"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/06/22 08:10
S5	1	"5258954".PN.	US-PGPUB; USPAT	OR	ON	2004/06/22 09:01
S6	5	((US-4233674-\$ or US-4007452-\$).did.).p57-p127. or ((EP-480752-\$ or EP-590982-\$).did.).p47-p50.) OR "5424988".PN.	USPAT; EPO	OR	ON	2004/06/22 08:58
S7	1	"5276647".PN.	US-PGPUB; USPAT	OR	ON	2004/06/22 09:03
S8	1	"5812469".PN.	US-PGPUB; USPAT	OR	ON	2004/06/22 10:21
S9	51	"semiconductor memory" AND (bitlines OR "bit lines") AND "same logic state"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/18 12:20
S12	32	test AND "semiconductor memory" AND "same logic state"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/18 12:20
S15	2195	(714/724 OR 714/733-734 OR 714/745) AND @ad<"20010809"	US-PGPUB; USPAT	OR	ON	2004/12/18 12:21
S16	169	test AND "same logic state" NOT "semiconductor memory"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/18 12:21

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test and "semiconductor
memory" and "same logic state"

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